PCI/PXI/ USB-6281 Specifications

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NI 6281 Specifications

Analog Input

Number of channels	8 differential or 16 single ended
ADC resolution	18 bits
DNL	No missing codes guaranteed
INL	Refer to the <u>AI Absolute Accuracy</u> section
Sample rate	
Single channel maximum	625 kS/s
Multichannel maximum (aggregate)	500 kS/s
Minimum	No minimum
Minimum Timing accuracy	No minimum 50 ppm of sample rate
Timing accuracy	50 ppm of sample rate
Timing accuracy Timing resolution	50 ppm of sample rate 50 ns

CMRR (DC to 60 Hz)		110 dB			
Input impedance					
Device on					
Al+ to Al GND $>10 \text{ G}\Omega$ in parallel with 100 pF					
AI- to AI GND	>10 G Ω in parallel with	100 pF			
Device off					
AI+ to AI GND		820 Ω			
AI- to AI GND		820 Ω			
Input bias current		±100 pA			
Crosstalk (at 100 kHz)		75 15			
Adjacent channels		-75 dB			
Non-adjacent channels		-95 dB			
Small signal bandwidth	(-3 dB)	750 kHz filter off, 40 kHz filter on			
Input FIFO size		2,047 samples			
Scan list memory		4,095 entries			
Data transfers					
PCI/PXI DMA (scati	ter-gather), interrupts, prograr	mmed I/O			

USB	USB Signal Stream, programmed I/O							
Overvoltag	Overvoltage protection for all analog input and sense channels							
Device on	±25 V 1	for up to eig	ht AI pins					
Device off	Device off ±15 V for up to eight AI pins							
Input current during overvoltage condition ±20 mA maximum/AI pin								
			-4 ppm of Step r Full-Scale	Filter On ±4 ppm of Step (±1 LSB for Full-Scale				

Step) Step) Step) ±5 V, ±10 V 8 μs $2 \mu s$ 50 μs $\pm 0.5 \text{ V}, \pm 1 \text{ V}, \pm 2 \text{ V} 2.5 \,\mu\text{s}$ 8 µs 50 μs $\pm 0.1 \text{ V}, \pm 0.2 \text{ V}$ 3 µs 8 µs 50 μs

Table 5. Settling Time for Multichannel Measurements

Typical Performance Graphs

Figure 1. AI Settling Error versus Time for Different Source Impedances

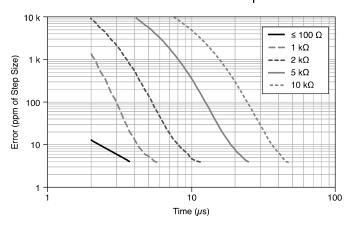


Figure 2. AI Small Signal Bandwidth

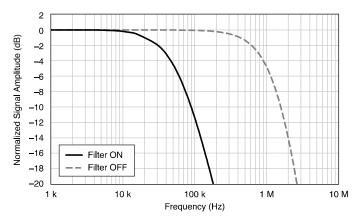
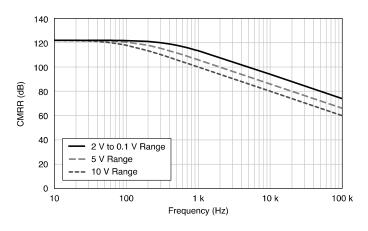


Figure 3. AI CMRR



AI Absolute Accuracy

AI Absolute Accuracy (Filter On)

Note Accuracies listed are valid for up to two years from the device external calibration.

Nominal Range Positive Full Scale	Nominal Range Negative Full Scale	Residual Gain Error (ppm of Reading)	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	Random Noise, σ (μVrms)	Absolute Accuracy at Full Scale (µV)	Sensitivity (μV)
10	-10	40	8	11	60	980	24
5	-5	45	8	11	30	510	12

Nominal Range Positive Full Scale	Nominal Range Negative Full Scale	Residual Gain Error (ppm of Reading)	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	Random Noise, σ (μVrms)	Absolute Accuracy at Full Scale (µV)	Sensitivity (μV)
2	-2	45	8	13	12	210	4.8
1	-1	55	15	15	7	120	2.8
0.5	-0.5	55	30	20	4	70	1.6
0.2	-0.2	75	45	35	3	39	1.2
0.1	-0.1	120	60	60	2	28	0.8

Table 5. Al Absolute Accuracy (Filter On)

Note Sensitivity is the smallest voltage change that can be detected. It is a function of noise.

Gain tempco	17 ppm/°C
Reference tempco	1 ppm/°C
INL error	10 ppm of range

AI Absolute Accuracy (Filter Off)

Note Accuracies listed are valid for up to two years from the device external calibration.

Nominal Range Positive Full Scale	Nominal Range Negative Full Scale	Residual Gain Error (ppm of Reading)	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	Random Noise, σ (μVrms)	Absolute Accuracy at Full Scale (μV)	Sensitivity (μV)
10	-10	45	10	11	70	1,050	28.0
5	-5	50	10	11	35	550	14.0
2	-2	50	10	13	15	230	6.0
1	-1	60	17	15	12	130	4.8

Nominal	Nominal	Residual	Residual	Offset	Random	Absolute	Sensitivity
Range	Range	Gain Error	Offset	Tempco	Noise, σ	Accuracy	(μV)
Positive	Negative	(ppm of	Error (ppm	(ppm of	(μVrms)	at Full	
Full Scale	Full Scale	Reading)	of Range)	Range/°C)		Scale (µV)	
0.5	-0.5	60	32	20	10	80	4.0
0.2	-0.2	80	47	35	9	43	3.6
0.1	-0.1	120	62	60	9	31	3.6

Table 5. AI Absolute Accuracy (Filter Off)

Note Sensitivity is the smallest voltage change that can be detected. It is a function of noise.

Gain tempco	17 ppm/°C
Reference tempco	1 ppm/°C
INL error	10 ppm of range

Al Absolute Accuracy Equation

AbsoluteAccuracy = Reading \cdot (GainError) + Range \cdot (OffsetError) + NoiseUncertainty

- GainError = ResidualAIGainError + GainTempco
- · (TempChangeFromLastInternalCal) + ReferenceTempco · (TempChangeFromLastExternalCal)
- OffsetError = ResidualAIOffsetError + OffsetTempco · (TempChangeFromLastInternalCal) + INLError
- NoiseUncertainty =

$$\frac{\text{Random Noise}}{\sqrt{100}}$$

for a coverage factor of 3 σ and averaging 100 points.

Al Absolute Accuracy Example

Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

- TempChangeFromLastExternalCal = 10 °C
- TempChangeFromLastInternalCal = 1 °C
- number_of_readings = 100
- CoverageFactor = 3 σ

For example, on the 10 V range of the Filter On accuracy table, the absolute accuracy at full scale is as follows:

- GainError = $40 \text{ ppm} + 17 \text{ ppm} \cdot 1 + 1 \text{ ppm} \cdot 10 = 67 \text{ ppm}$
- OffsetError = 8 ppm + 11 ppm · 1 + 10 ppm = 29 ppm
- NoiseUncertainty =

$$\frac{60 \ \mu V}{\sqrt{100}}$$

 $= 18 \mu V$

AbsoluteAccuracy = 10 V · (GainError) + 10 V · (OffsetError) + NoiseUncertainty = 980 μV

Analog Triggers

Number of triggers	1
Source	Al <015>, APFI 0
Functions	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase
Source level Al <015>	±Full scale

APFI 0	±10 V			
Resolution	10 bits, 1 in 1,024			
Modes	Analog edge triggering, analog edge triggering window triggering	with hysteresis, and analog		
Bandwidth (-3	dB)			
AI <015>	700 kHz filter off, 40 kHz filter on			
APFI 0	5 MHz			
Accuracy	±1%			
APFI 0 characte	eristics			
Input impedance	ee	10 kΩ		
Coupling		DC		
Protection, power on ±30 V				
Protection, power off ±15 V				

Analog Output

Number of channels	2
DAC resolution	16 bits
DNL	±1 LSB

Monotonicity	16 bit guaranteed	I
Accuracy	Refer to the <u>AO Al</u>	osolute Accuracy section
Maximum update rate		
1 channel	2.86 MS/s	
2 channels	2.00 MS/s per channel	
Timing accuracy	50 ppm of sample	e rate
Timing resolution	50 ns	
Output range (offset ± refe		
Calibrated ranges	±1 V, ±2 V, ±5 V, ±10 V	
Offset sources	0 V, 5 V, APFI 0 , AO <0,1 >[1]	
Reference sources	1 V, 5 V, 2 V, 10 V, APFI 0, AO <0,1>[2]	
Maximum output level	±11 V	
Output coupling	DC	
Output impedance	0.2 Ω	
Output current drive	±5 mA	
Overdrive protection	±25 V	
Overdrive current	20 mA	

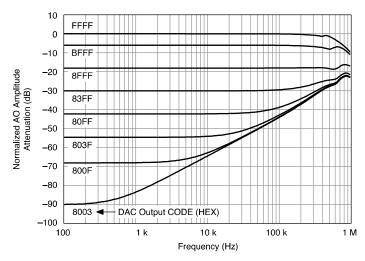
Power-on state[3]	±5 mV	
Power-on glitch	2.3 V peak for 1.2 s	
Output FIFO size	8,191 samples shared among channels used	
Data transfers		
PCI/PXI DMA (scatter-gather), interrup	ts, programmed I/O	
USB USB Signal Stream, programm	ned I/O	
AO waveform modes	Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update	
Settling time, full-scale step, 15 ppm (1 LSB)	3 μs	
Slew rate	20 V/μs	
Glitch energy at midscale transition, ±10 V	V range	
Magnitude	15 mV	
Duration	0.5 μs	

External Reference

APFI 0 characteristics	
Input impedance	10 kΩ
Coupling	DC

Protection, de	vice on	±30 V
Protection, de	vice off	±15 V
Range		±11 V

Figure 4. AO <0,1> External Reference Bandwidth



AO Absolute Accuracy

Absolute accuracy at full-scale numbers is valid immediately following internal calibration and assumes the device is operating within 10 °C of the last external calibration.

> **Note** Accuracies listed are valid for up to two years from the device external calibration.

Nominal Range Positive Full	Nominal Range	Residual Gain Error (ppm of	Gain Tempco (ppm/°C)	Residual Offset Error (ppm of	Offset Tempco (ppm of Range/°C)	Absolute Accuracy at Full Scale
Scale	Full Scale	Reading)	(рртт, с)	Range)	or Range, e,	(μV)
10	-10	55	15	30	12	1,540
5	-5	60	15	30	17	820

Nominal	Nominal	Residual	Gain	Residual	Offset	Absolute
Range Positive Full	Range Negative	Gain Error (ppm of	Tempco (ppm/°C)		Tempco (ppm of Range/°C)	Full Scale
Scale	Full Scale	Reading)	, ,	Range)		(μV)
2	-2	65	25	40	30	404
1	-1	85	25	57	50	259

Table 5. AO Absolute Accuracy

Reference tempco	1 ppm/°C
INL error	32 ppm of range

AO Absolute Accuracy Equation

AbsoluteAccuracy = OutputValue · (GainError) + Range · (OffsetError)

- GainError = ResidualGainError + GainTempco
- $\cdot (TempChangeFromLastInternalCal) + ReferenceTempco \cdot \\ (TempChangeFromLastExternalCal)$
- OffsetError = ResidualOffsetError + AOOffsetTempco · (TempChangeFromLastInternalCal) + INLError

Digital I/O/PFI

Static Characteristics

Number of channels	24 total, 8 (P0.<07>), 16 (PFI <07>/P1, PFI <815>/P2)
I/O type	5 V TTL/CMOS compatible
Ground reference	D GND
Direction control	Each terminal individually programmable as input or output

Pull-down resistor	50 kΩ typical, 20 kΩ minimum
Input voltage protection	±20 V on up to two pins[4]

Waveform Characteristics (Port 0 Only)

Terminals used	Port 0 (P0.<07>)
Port/sample size	Up to 8 bits
Waveform generation (DO) FIFO	2,047 samples
Waveform acquisition (DI) FIFO	2,047 samples

DI Sample Clock frequency

PCI/PXI 0 MHz to 10 MHz, system and bus activity dependent

USB 0 MHz to 1 MHz, system and bus activity dependent

DO Sample Clock frequency

PCI/PXI

Regenerate from FIFO 0 MHz to 10 MHz

Streaming from memory 0 MHz to 10 MHz, system and bus activity dependent

USB

Regenerate from FIFO 0 MHz to 10 MHz

Streaming from memory 0 MHz to 1 MHz, system and bus activity dependent

Data transfers

PCI/PXI DMA (scatter-gather), interrupts, programmed I/O

USB Signal Stream, programmed I/O

DI or DO Sample Clock source [5] Any PFI, RTSI, AI Sample or Convert Clock, AO Sample Clock, Ctr **n** Internal Output, and many other signals

PFI/Port 1/Port 2 Functionality

Functionality	Static digital input, static digital output, timing input, timing output
Timing output sources	Many AI, AO, counter, DI, DO timing signals
Debounce filter settings	125 ns, 6.425 μs, 2.56 ms, disable; high and low transitions; selectable per input

Recommended Operating Conditions

Level	Minimum	Maximum
Input high voltage (V _{IH})	2.2 V	5.25 V
Input low voltage (V _{IL})	0 V	0.8 V
Output high current (I _{OH}) P0.<07>	_	-24 mA
Output high current (I _{OH}) PFI <015>/P1/P2	_	-16 mA
Output low current (I _{OL}) P0.<07>	_	24 mA
Output low current (I _{OL}) PFI <015>/P1/P2	_	16 mA

Electrical Characteristics

Level	Minimum	Maximum
Positive-going threshold (VT+)	_	2.2 V
Negative-going threshold (VT-)	0.8 V	_
Delta VT hystersis (VT+ - VT-)	0.2 V	_
I _{IL} input low current (V _{in} = 0 V)	_	-10 μΑ
I _{IH} input high current (V _{in} = 5 V)	_	250 μΑ

Digital I/O Characteristics

Figure 5. Digital I/O (P0.<0..7>): I_{oh} versus V_{oh}

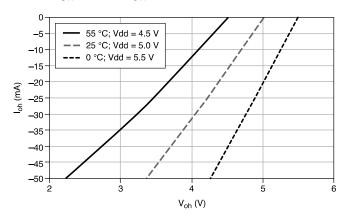


Figure 6. Digital I/O (PFI <0..15>/P1/P2): I_{oh} versus V_{oh}

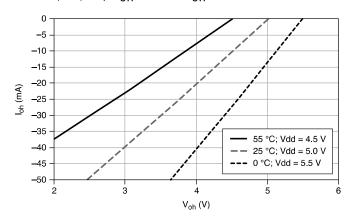


Figure 7. Digital I/O (P0.<0..7>): I_{ol} versus V_{ol}

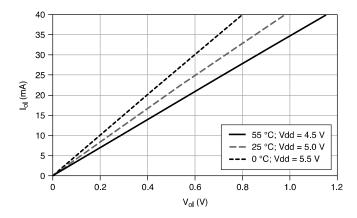
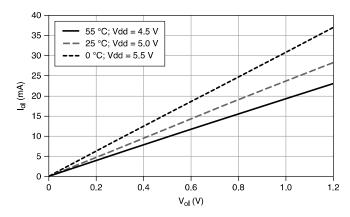


Figure 8. Digital I/O (PFI <0..15>/P1/P2): I_{ol} versus V_{ol}



General-Purpose Counters/Timers

Number of counter/timers	2
Resolution	32 bits
Counter measurements	Edge counting, pulse, semi-period, period, two-edge separation
Position measurements	X1, X2, X4 quadrature encoding with Channel Z reloading; two- pulse encoding

Output applications	Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling
Internal base clocks	80 MHz, 20 MHz, 0.1 MHz
External base clock frequency	0 MHz to 20 MHz
Base clock accuracy	50 ppm
Inputs	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Routing options for inputs	Any PFI, RTSI, PXI_TRIG, PXI_STAR, analog trigger, many internal signals
FIFO	2 samples

Data transfers

PCI/PXI Dedicated scatter-gather DMA controller for each counter/timer; interrupts, programmed I/O

USB USB Signal Stream, programmed I/O

Frequency Generator

Number of channels	1
Base clocks	10 MHz, 100 kHz
Divisors	1 to 16
Base clock accuracy	50 ppm

Output can be available on any output PFI or RTSI terminal.

Phase-Locked Loop (PLL)

Note PCI/PXI devices only.

Number of PLLs	1
Reference signal	PXI_STAR, PXI_CLK10, RTSI <07>
Output of PLL	80 MHz Timebase; other signals derived from 80 MHz Timebase including 20 MHz and 100 kHz Timebases

External Digital Triggers

Source	Any PFI, RTSI, PXI_TRIG, PXI_STAR
Polarity	Software-selectable for most signals
Analog input function	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase
Analog output function	Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase
Counter/timer function	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Digital waveform generation (DO) function	Sample Clock
Digital waveform acquisition (DI) function	Sample Clock

Device-to-Device Trigger Bus

PCI	RTSI <07>[6]
PXI	PXI_TRIG <07>, PXI_STAR
USB source	None
Output selections	10 MHz Clock, frequency generator output, many internal signals
Debounce filter settings	125 ns, 6.425 μ s, 2.56 ms, disable; high and low transitions; selectable per input

Bus Interface

PCI/PXI	3.3 V or 5 V signal environment
USB	USB 2.0 Hi-Speed or full-speed [7], [8]
DMA channels (PCI/PXI)	6, can be used for analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1
USB Signal Stream	4, can be used for analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1

The PXI device supports one of the following features:

- May be installed in PXI Express hybrid slots
- Or, may be used to control SCXI in PXI/SCXI combo chassis

M Series Part Number	·	PXI Express Hybrid Slot Compatible
191501C-03	No	Yes

M Series Part Number	SCXI Control in PXI/SCXI Combo Chassis	PXI Express Hybrid Slot Compatible
191501A-0 x /191501B-0 x	Yes	No

Table 5. PXI/SCXI Combo and PXI Express Chassis Compatibility

Power Requirements

PCI/PXI		
Current draw from bus during no-load condition[9]		
+5 V	0.03 A	
+3.3 V	0.78 A	
+12 V	0.40 A	
-12 V	0.06 A	
	g AI and AO overvoltage condition ^[9]	
+5 V	0.03 A	
+3.3 V	1.26 A	
+12 V	0.43 A	
-12 V	0.06 A	

Caution USB devices must be powered with an NI offered AC adapter or a National Electric Code (NEC) Class 2 DC source that meets the power requirements for the device and has appropriate safety certification marks for country of use.

USB

Power supply requirements 11 to 30 VDC, 20 W, locking or non-locking power jack with 0.080 in.

diameter center pin, 5/16-32 thread for locking collars

Power supply fuse 2 A, 250 V

Current Limits

Caution Exceeding the current limits may cause unpredictable behavior by the device and/or PC/chassis.

PCI, +5 V terminal	1 A max ^[10]	
PXI		
+5 V terminal		1 A max $\underline{^{[10]}}$
P0/PFI/P1/P2 and +5 V terminals combined		2 A max
USB		
+5 V terminal		1 A max[11]
P0/PFI/P1/P2 and +5 V terminals combined		2 A max

Physical Characteristics

Dimensions

PCI printed circuit board $10.6 \text{ cm} \times 15.5 \text{ cm} (4.2 \text{ in.} \times 6.1 \text{ in.})$ PXI printed circuit board Standard 3U PXI

Mass Termination $18.8 \text{ cm} \times 17.09 \text{ cm} \times 100 \text{ cm}$

enclosure (includes connectors) 4.45 cm $(7.4 \text{ in.} \times 6.73 \text{ in.} \times 1.75 \text{ in.})$

Screw Terminal (includes connectors) 26.67 cm × 17.09 cm ×

4.45 cm(10.5 in. × 6.73 in. × 1.75 in.)

USB OEM Refer to the **NI USB-622x/625x/628x OEM User**

Guide

Weight

PCI 158 g (5.6 oz)

PXI 225 g (7.9 oz)

USB Mass Termination 1.04 kg (2 lb4.5 oz)

USB Screw Terminal 1.46 kg (3 lb3.4 oz)

USB OEM 261 g (9.2 oz)

I/O connectors

Mass Termination 1 68-pin SCSI

USB OEM 1 34-pin IDC, 1 50-pin IDC

Screw terminal wiring 16 AWG to 28 AWG

Calibration

Recommended warm-up time

PCI/PXI/PCI Express/PXI Express	15 minutes
USB	30 minutes
Calibration interval	2 years

Maximum Working Voltage

Connect only voltages that are below these limits.

Channel-to-earth	11 V, Measurement Category I

Measurement Category I is for measurements performed on circuits not directly connected to the electrical distribution system referred to as MAINS voltage. MAINS is a hazardous live electrical supply system that powers equipment. This category is for measurements of voltages from specially protected secondary circuits. Such voltage measurements include signal levels, special equipment, limited-energy parts of equipment, circuits powered by regulated low-voltage sources, and electronics.

Caution Do not use for measurements within Categories II, III, or IV.

Note Measurement Categories CAT I and CAT O (Other) are equivalent. These test and measurement circuits are not intended for direct connection to the MAINS building installations of Measurement Categories CAT II, CAT III, or CAT IV.

Environmental

Operating temperat	ure	
PCI/PXI	0 °C to 55 °C	

USB	0 °C to 45 °C
Storage temperature	-20 °C to 70 °C
Humidity	10% RH to 90% RH, noncondensing
Maximum altitude	2,000 m
Pollution Degree (indoor use only)	2

Indoor use only.

Shock and Vibration (PXI Only)

	30 g peak, half-sine, 11 ms pulse (Tested in accordance with IEC 60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.)
--	---

Random vibration

Operating 5 Hz to 500 Hz, 0.3 g_{rms}

Nonoperating 5 Hz to 500 Hz, 2.4 g_{rms} (Tested in accordance with IEC 60068-2-64. Nonoperating test profile exceeds the requirements of MIL-PRF-28800F, Class 3.)

Safety Compliance Standards

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA C22.2 No. 61010-1

Note For safety certifications, refer to the product label or the Product Certifications and Declarations section.

Electromagnetic Compatibility

CE Compliance €

2011/65/EU; Restriction of Hazardous Substances (RoHS)

Product Certifications and Declarations

Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for NI products, visit ni.com/product-certifications, search by model number, and click the appropriate link.

Environmental Management

NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the **Engineering a Healthy Planet** web page at <u>ni.com/environment</u>. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

EU and UK Customers

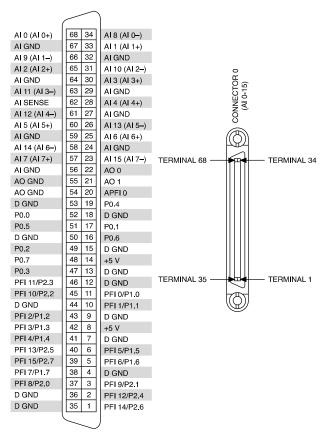
• 🗷 Waste Electrical and Electronic Equipment (WEEE)—At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit <u>ni.com/environment/weee</u>.

电子信息产品污染控制管理办法(中国 RoHS)

• ●●● 中国 RoHS— NI 符合中国电子信息产品中限制使用某些有害物质指令(RoHS)。关于 NI 中国 RoHS 合规性信息,请登录 ni.com/environment/rohs_china。(For information about China RoHS compliance, go to ni.com/environment/rohs_china.)

Device Pinouts

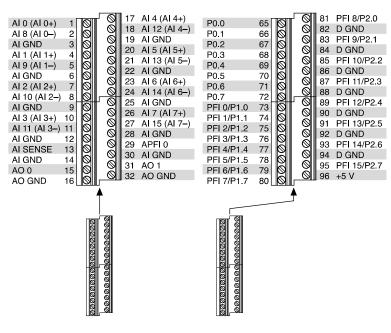
Figure 9. NI PCI/PXI-6281 Pinout



CONNECTOR 0 (AI 0-15) AI 0 (AI 0+) 68 34 AI 8 (AI 0-) AI GND 67 33 AI 1 (AI 1+) AI 9 (AI 1-) 66 32 AI GND AI 2 (AI 2+) AI 10 (AI 2-) 65 31 AI GND 64 30 Al 3 (Al 3+) 0 AI 11 (AI 3-) 63 29 AI GND AI SENSE 62 28 Al 4 (Al 4+) AI 12 (AI 4-) 61 27 AI GND AI 5 (AI 5+) Al 13 (Al 5-) 60 26 AI GND 59 25 AI 6 (AI 6+) AI 14 (AI 6-) 58 24 AI GND 57 23 AI 7 (AI 7+) AI 15 (AI 7-) AI GND 56 22 AO 0 AO GND 55 21 AO 1 AO GND 54 20 APFI0 D GND 53 19 P0.4 52 18 D GND P0.0 P0.5 51 17 P0.1 D GND 50 16 P0.6 P0.2 49 15 D GND +5 V P0.7 48 14 P0.3 47 13 D GND PFI 11/P2.3 46 12 D GND PFI 10/P2.2 45 11 PFI 0/P1.0 D GND 44 10 PFI 1/P1.1 PFI 2/P1.2 D GND 43 9 PFI 3/P1.3 42 8 +5 V PFI 4/P1.4 41 7 D GND PFI 13/P2.5 40 6 PFI 5/P1.5 PFI 15/P2.7 39 5 PFI 6/P1.6 **①** PFI 7/P1.7 38 4 D GND PFI 8/P2.0 37 3 PFI 9/P2.1 D GND 36 2 PFI 12/P2.4 D GND 35 1

Figure 10. NI USB-6281 Mass Termination Pinout

Figure 11. NI USB-6281 Screw Terminal Pinout



- ¹ An AO channel cannot be a reference or offset to itself.
- ² When the USB Screw Terminal device is powered on, the analog output signal is not defined until after the USB configuration is complete.
- ³ For all USB Screw Terminal devices, when powered on, the analog output signal is not defined until after USB configuration is complete.
- ⁴ Stresses beyond those listed under **Input voltage protection** may cause permanent damage to the device.
- ⁵ The digital subsystem does not have its own dedicated internal timing engine. Therefore, a sample clock must be provided from another subsystem on the device or an external source.
- ⁶ In other sections of this document, RTSI refers to RTSI <0..7> for the PCI devices or PXI_TRIG <0..7> for PXI devices.
- ⁷ If you are using an USB M Series device in full-speed mode, device performance will be lower and you will not be able to achieve maximum sample/update rates.
- ⁸Operating on a full-speed bus may result in lower performance.
- ⁹ Does not include P0/PFI/P1/P2 and +5 V terminals.
- 10 Older revisions have a self-resetting fuse that opens when current exceeds this specification. Newer revisions have a traditional fuse that opens when current exceeds this specification. This fuse is not customer-replaceable; if the fuse permanently opens, return the device to NI for repair.
- $\frac{11}{2}$ Has a user-replaceable socketed fuse that opens when current exceeds this specification. Refer to the M Series for information about fuse replacement.